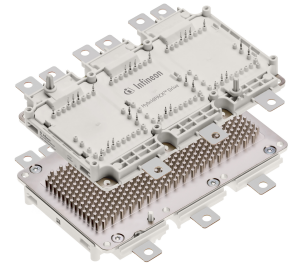


HybridPACK™ Drive module with CoolSiC™ Automotive MOSFET

Features

- Electrical features
 - $V_{DS} = 1200\text{ V}$
 - $I_{D,nom} = 200\text{ A}$
 - New semiconductor material - silicon carbide
 - Blocking voltage 1200 V
 - Low $R_{DS,on}$
 - Low switching losses
 - Low Q_g and C_{rss}
 - $T_{vj,op} = 150^\circ\text{C}$
 - Low inductive design <10 nH
- Mechanical features
 - 4.2 kV DC 1 second insulation
 - High creepage and clearance distances
 - Compact design
 - High power density
 - Direct-cooled PinFin base plate
 - High-performance Si3N4 ceramic
 - Guiding elements for PCB and cooler assembly
 - Integrated NTC temperature sensor
 - PressFIT contact technology
 - RoHS compliant
 - UL 94 V0 module frame



Potential applications

- Automotive applications
- (Hybrid) electrical vehicles (H)EV
- Motor drives
- Commercial agriculture vehicles

Product validation

- Qualified according to AQC 324, release no.: 03.1/2021

Description

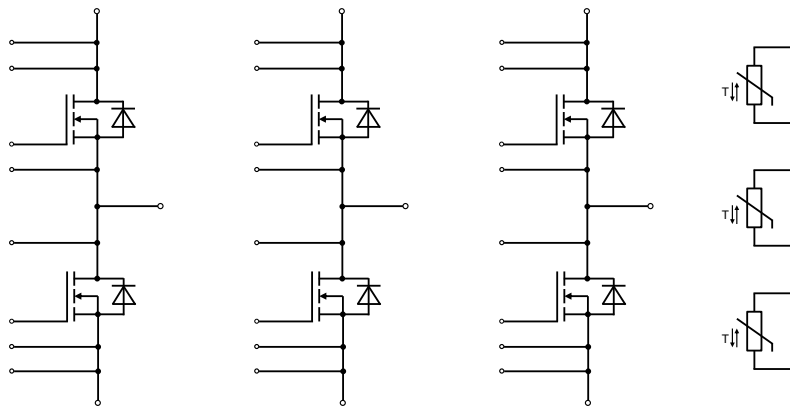


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1 Package

Table 1 Insulation coordination

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	V_{ISOL}	RMS, $f = 0$ Hz, $t = 1$ sec	4.20	kV
Material of module baseplate			Cu+Ni ¹⁾	
Internal isolation		basic insulation (class 1, IEC 61140)	Si3N4	
Creepage distance	d_{creep}	terminal to heatsink	9.0	mm
Creepage distance	d_{creep}	terminal to terminal	9.0	mm
Clearance	d_{clear}	terminal to heatsink	4.5	mm
Clearance	d_{clear}	terminal to terminal	4.5	mm
Comparative tracking index	CTI		> 200	

1) Ni plated Cu baseplate.

Table 2 Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit
Maximum RMS module terminal current	$I_{t,rms}$	$T_{terminal} = 105$ °C, $T_f = 75$ °C	550	A

Table 3 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Pressure drop in cooling circuit	Δp	$\Delta V/\Delta t = 10$ dm ³ /min, 50% water/ 50% ethylenglycol, $T_f = 60$ °C		64 ¹⁾		mbar
Maximum pressure in cooling circuit	p	$T_{baseplate} < 40$ °C (relative pressure)			2.5	bar
		$T_{baseplate} \geq 40$ °C (relative pressure)			2.0	
Stray inductance module	$L_{s,DS}$			8.5		nH
Module lead resistance, terminals - chip	$R_{DD'+SS'}$	$T_f = 25$ °C, per switch		0.75		mΩ
Storage temperature	T_{stg}		-40		125	°C
Mounting torque for module mounting	M	Screw M4 baseplate to heatsink	1.8	2.0	2.2	Nm
Weight	G			720		g

1) Cooler design and flow direction according to application note AN-HPD-ASSEMBLY.

2 MOSFET

Table 4 Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit
Drain-source voltage	V_{DS}	$T_{vj} = 25\text{ °C}$	1200	V
DC drain current	$I_{D,nom}$	$V_{GS} = 15\text{ V}$, $T_f = 60\text{ °C}$ $T_{vj,max} = 175\text{ °C}$	200	A
Pulsed drain current	$I_{D,pulse}$	verified by design, t_p limited by $T_{vj,max}$	400	A
Gate-source voltage	V_{GSS}		-10/20	V

Table 5 Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
Drain-source on-resistance	$R_{DS,on}$	$I_D = 200\text{ A}$, $V_{GS} = 15\text{ V}$	$T_{vj} = 25\text{ °C}$		5.50	7.35	mΩ
			$T_{vj} = 125\text{ °C}$		8.00		
			$T_{vj} = 150\text{ °C}$		9.10		
Gate threshold voltage	$V_{GS,th}$	$I_D = 120\text{ mA}$, $V_{GS} = V_{DS}$, (tested after 1ms pulse at $V_{GS} = +20\text{ V}$)	$T_{vj} = 25\text{ °C}$	3.25	4.50	5.55	V
Total gate charge	Q_G	$V_{DS} = 600\text{ V}$, $V_{GS} = -5/15\text{ V}$			0.66		μC
Internal gate resistor	$R_{G,int}$		$T_{vj} = 25\text{ °C}$		0.45		Ω
Input capacitance	C_{iss}	$f = 1\text{ MHz}$, $V_{DS} = 600\text{ V}$, $V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$		21.3		nF
Output capacitance	C_{oss}	$f = 1\text{ MHz}$, $V_{DS} = 600\text{ V}$, $V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$		0.93		nF
Reverse transfer capacitance	C_{rss}	$f = 1\text{ MHz}$, $V_{DS} = 600\text{ V}$, $V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$		0.09		nF
C_{oss} stored energy	E_{oss}	$V_{DS} = 600\text{ V}$, $V_{GS} = -5/15\text{ V}$	$T_{vj} = 25\text{ °C}$		219		μJ
Drain-source leakage current	I_{DSX}	$V_{GS} = -5\text{ V}$, $V_{DSS} = 1200\text{ V}$	$T_{vj} = 25\text{ °C}$			100	μA
Gate-source leakage current	I_{GSS}	$V_{GS} = 20\text{ V}$, $V_{DS} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$			400	nA
Turn-on delay time, inductive load	$t_{d,on}$	$I_D = 200\text{ A}$, $R_{G,on} = 5.1\text{ Ω}$, $V_{GS} = -5/15\text{ V}$, $V_{DS} = 600\text{ V}$	$T_{vj} = 25\text{ °C}$		52		ns
			$T_{vj} = 125\text{ °C}$		45		
			$T_{vj} = 150\text{ °C}$		44		
Rise time (inductive load)	t_r	$I_D = 200\text{ A}$, $R_{G,on} = 5.1\text{ Ω}$, $V_{GS} = -5/15\text{ V}$, $V_{DS} = 600\text{ V}$	$T_{vj} = 25\text{ °C}$		44		ns
			$T_{vj} = 125\text{ °C}$		40		
			$T_{vj} = 150\text{ °C}$		39		

(table continues...)

Table 5 (continued) Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Turn-off delay time, inductive load	$t_{d,off}$	$I_D = 200\text{ A}$, $R_{G,off} = 5.1\ \Omega$, $V_{GS} = -5/15\text{ V}$, $V_{DS} = 600\text{ V}$	$T_{vj} = 25\text{ °C}$	142		ns
			$T_{vj} = 125\text{ °C}$	153		
			$T_{vj} = 150\text{ °C}$	156		
Fall time (inductive load)	t_f	$I_D = 200\text{ A}$, $R_{G,off} = 5.1\ \Omega$, $V_{GS} = -5/15\text{ V}$, $V_{DS} = 600\text{ V}$	$T_{vj} = 25\text{ °C}$	52		ns
			$T_{vj} = 125\text{ °C}$	53		
			$T_{vj} = 150\text{ °C}$	53		
Turn-on energy loss per pulse	E_{on}	$I_D = 200\text{ A}$, $R_{G,on} = 5.1\ \Omega$, $V_{GS} = -5/15\text{ V}$, $V_{DS} = 600\text{ V}$, $L_\sigma = 20\text{ nH}$	$T_{vj} = 25\text{ °C}$	6.04		mJ
			$T_{vj} = 125\text{ °C}$	6.66		
			$T_{vj} = 150\text{ °C}$, $di/dt = 4.5\text{ kA}/\mu\text{s}$	6.83		
Turn-off energy loss per pulse	E_{off}	$I_D = 200\text{ A}$, $R_{G,off} = 5.1\ \Omega$, $V_{GS} = -5/15\text{ V}$, $V_{DS} = 600\text{ V}$, $L_\sigma = 20\text{ nH}$	$T_{vj} = 25\text{ °C}$	4.27		mJ
			$T_{vj} = 125\text{ °C}$	4.41		
			$T_{vj} = 150\text{ °C}$, $du/dt = 12.4\text{ kV}/\mu\text{s}$	4.51		
Short circuit data	I_{SC}	$V_{DD} = 800\text{ V}$, $V_{GS} = -5/15\text{ V}$, $R_{G,on} = 5.1\ \Omega$, $R_{G,off} = 5.1\ \Omega$, $V_{DSmax} = V_{DSS} - L_{SDS} \cdot di/dt$	$t_{SC} \leq 3\ \mu\text{s}$, $T_{vj} = 25\text{ °C}$	2730		A
			$t_{SC} \leq 3\ \mu\text{s}$, $T_{vj} = 150\text{ °C}$	2480		
Thermal resistance, junction to cooling fluid	$R_{th,j-f}$	per MOSFET, $T_f = 60\text{ °C}$, $\Delta V/\Delta t = 10\text{ dm}^3/\text{min}$, 50% water/ 50% ethylenglycol		0.15	0.18 ¹⁾	K/W
Temperature under switching conditions	$T_{vj,op}$		-40		150	°C

1) EoL criteria see AQG324, verified by characterization with 4.5 sigma. Cooler design and flow direction according to application note AN-HPDPERF-ASSEMBLY

3 Body diode

Table 6 Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit
DC body diode forward current	$I_{F,S}$	$T_{vj,max} = 175\text{ °C}$, $T_f = 60\text{ °C}$, $V_{GS} = -5\text{ V}$	110	A
Pulsed body diode current	$I_{F,S,pulse}$	verified by design, t_p limited by $T_{vj,max}$	400	A

Table 7 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Forward voltage	$V_{F,SD}$	$I_{F,S} = 200 \text{ A}$, $V_{GS} = -5 \text{ V}$	$T_{vj} = 25 \text{ °C}$	4.42	6.15	V
			$T_{vj} = 125 \text{ °C}$	4.22		
			$T_{vj} = 150 \text{ °C}$	4.16		
Peak reverse recovery current	I_{rrm}	$I_{F,S} = 200 \text{ A}$, $V_{GS} = -5 \text{ V}$, $V_{R,DS} = 600 \text{ V}$	$T_{vj} = 25 \text{ °C}$	87		A
			$T_{vj} = 125 \text{ °C}$	165		
			$T_{vj} = 150 \text{ °C}$	187		
Recovered charge	Q_{rr}	$I_{F,S} = 200 \text{ A}$, $V_{GS} = -5 \text{ V}$, $V_{R,DS} = 600 \text{ V}$	$T_{vj} = 25 \text{ °C}$	3.67		μC
			$T_{vj} = 125 \text{ °C}$	6.81		
			$T_{vj} = 150 \text{ °C}$	8.28		
Reverse recovery energy	E_{rec}	$I_{F,S} = 200 \text{ A}$, $V_{GS} = -5 \text{ V}$, $V_{R,DS} = 600 \text{ V}$	$T_{vj} = 25 \text{ °C}$, $-di/dt = 1.0 \text{ kA}/\mu\text{s}$	0.5		mJ
			$T_{vj} = 125 \text{ °C}$, $-di/dt = 1.0 \text{ kA}/\mu\text{s}$	1.1		
			$T_{vj} = 150 \text{ °C}$, $-di/dt = 1.0 \text{ kA}/\mu\text{s}$	1.4		

4 NTC-Thermistor

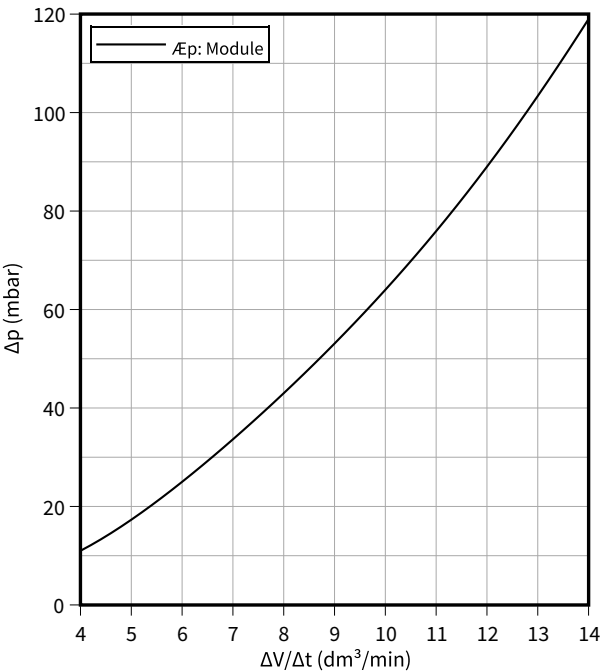
Table 8 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Rated resistance	R_{25}	$T_{NTC} = 25 \text{ °C}$		5		k Ω
Deviation of R_{100}	$\Delta R/R$	$T_{NTC} = 100 \text{ °C}$, $R_{100} = 493 \text{ }\Omega$	-5		5	%
Power dissipation	P_{25}	$T_{NTC} = 25 \text{ °C}$			20	mW
B-value	$B_{25/50}$	$R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298,15 \text{ K}))]$		3375		K
B-value	$B_{25/80}$	$R_2 = R_{25} \exp[B_{25/80}(1/T_2 - 1/(298,15 \text{ K}))]$		3411		K
B-value	$B_{25/100}$	$R_2 = R_{25} \exp[B_{25/100}(1/T_2 - 1/(298,15 \text{ K}))]$		3433		K

5 Characteristics diagrams

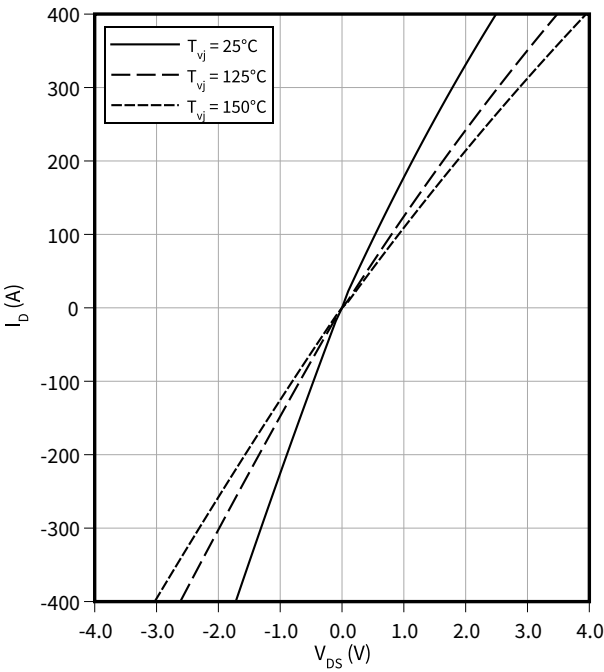
Pressure drop in cooling circuit, Package

$\Delta p = f(\Delta V/\Delta t)$
 $T_f = 60\text{ }^{\circ}\text{C}$, fluid = 50% water/ 50% ethylenglycol



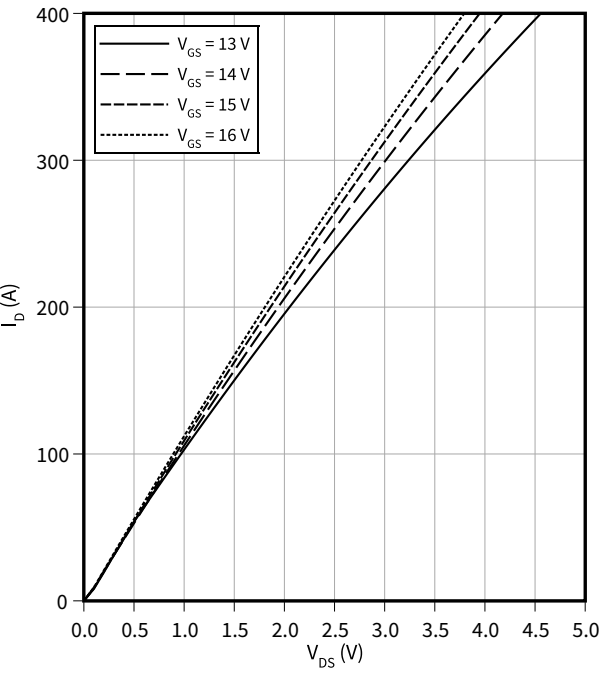
Output characteristic (typical), MOSFET

$I_D = f(V_{DS})$
 $V_{GS} = 15\text{ V}$



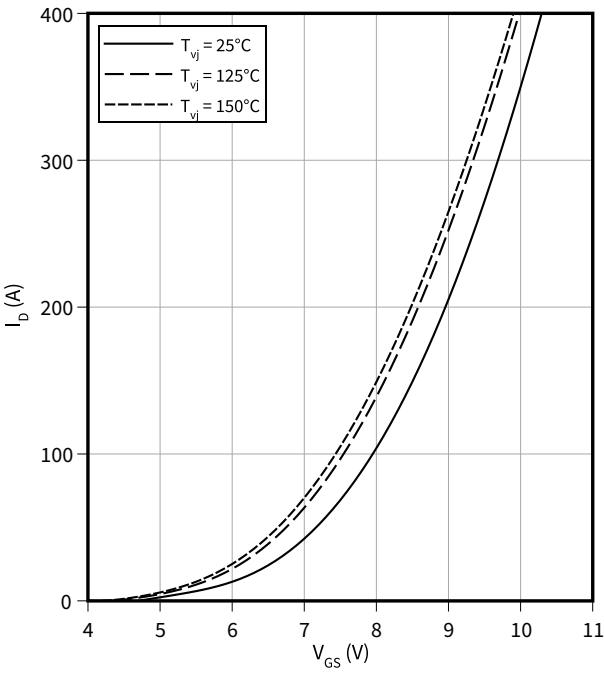
Output characteristic (typical), MOSFET

$I_D = f(V_{DS})$
 $T_{vj} = 125\text{ }^{\circ}\text{C}$



Transfer characteristic (typical), MOSFET

$I_D = f(V_{GS})$
 $V_{DS} = 20\text{ V}$

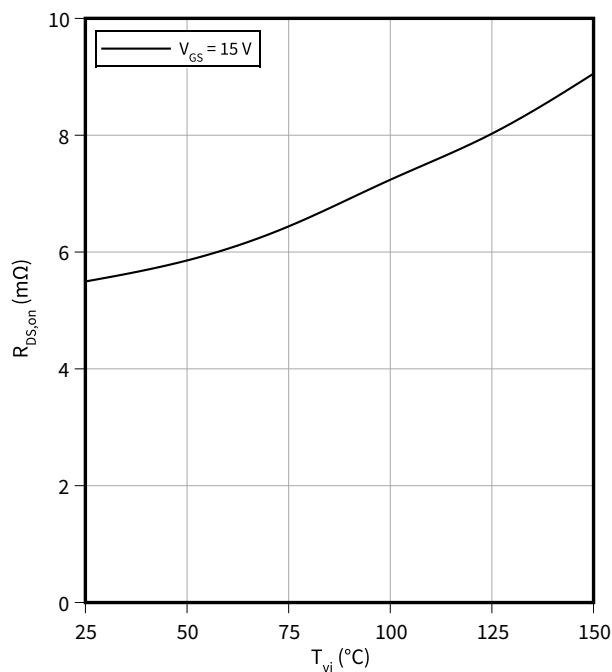


5 Characteristics diagrams

Drain-source on-resistance (typical), MOSFET

$$R_{DS,on} = f(T_{vj})$$

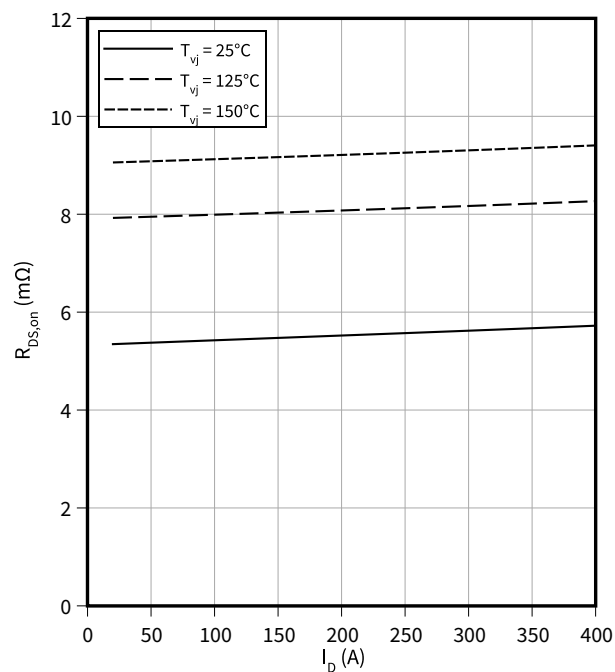
$$V_{GS} = 15 \text{ V}$$



Drain-source on-resistance (typical), MOSFET

$$R_{DS,on} = f(I_D)$$

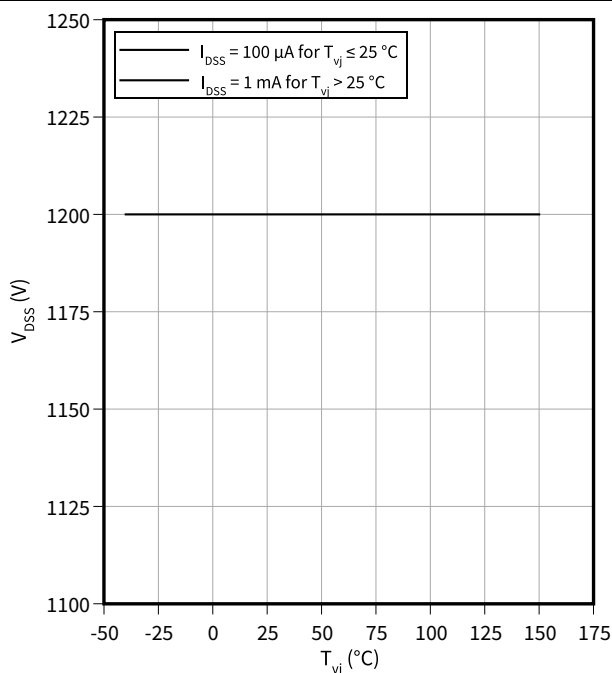
$$V_{GS} = 15 \text{ V}$$



Maximum allowed drain-source voltage, MOSFET

$$V_{DSS} = f(T_{vj})$$

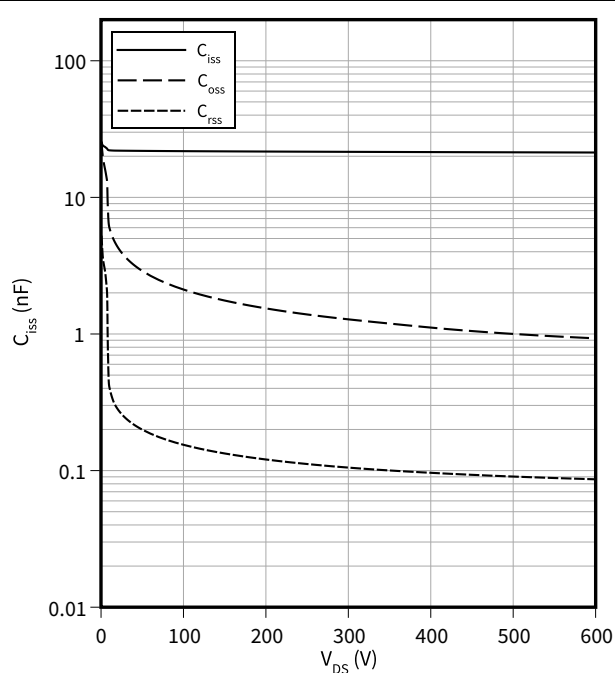
verified by characterization / design not by test



Capacity characteristic (typical), MOSFET

$$C_{iss} = f(V_{DS}), C_{rss} = f(V_{DS}), C_{oss} = f(V_{DS})$$

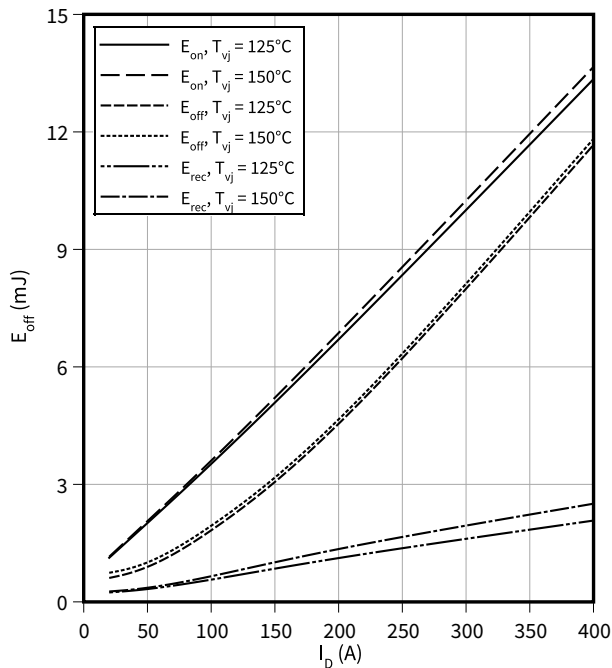
$$T_{vj} = 25^\circ\text{C}, f = 1 \text{ MHz}, V_{GS} = -5/15 \text{ V}$$



5 Characteristics diagrams

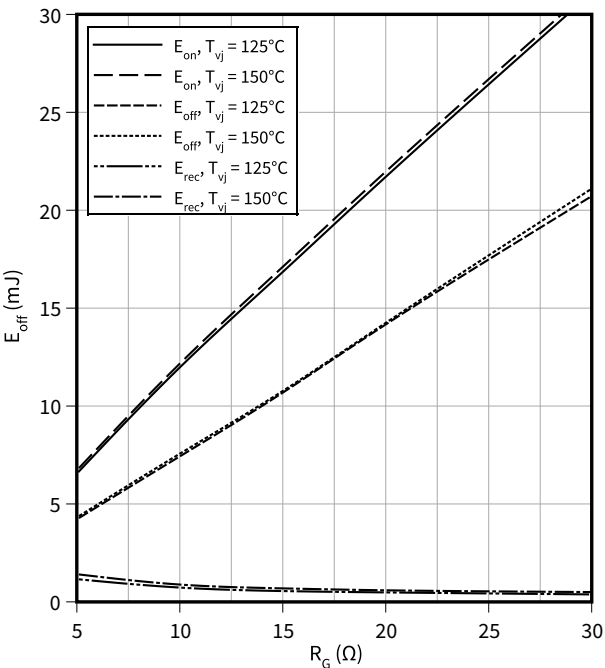
Switching losses (typical), MOSFET

$E_{off} = f(I_D)$, $E_{on} = f(I_D)$
 $V_{DS} = 600\text{ V}$, $R_{G,off} = 5.1\ \Omega$, $R_{G,on} = 5.1\ \Omega$, $V_{GS} = \pm 15\text{ V}$



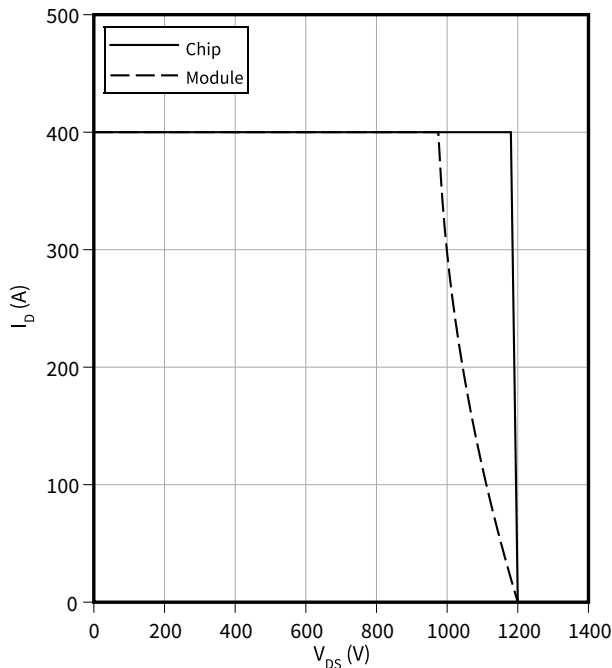
Switching losses (typical), MOSFET

$E_{off} = f(R_G)$, $E_{on} = f(R_G)$
 $I_D = 200\text{ A}$, $V_{DS} = 600\text{ V}$, $V_{GS} = -5/15\text{ V}$



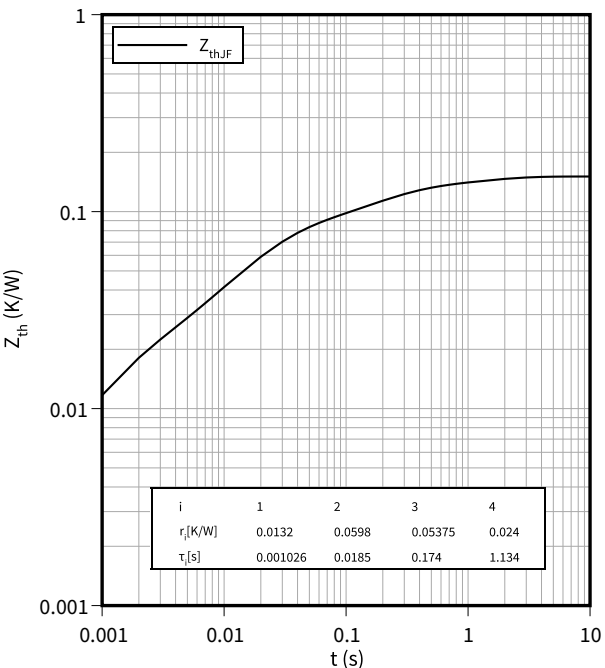
Reverse bias safe operating area (RBSOA), MOSFET

$I_D = f(V_{DS})$
 $V_{GS} = \pm 15\text{ V}$, $T_c = 60\text{ °C}$



Transient thermal impedance, MOSFET

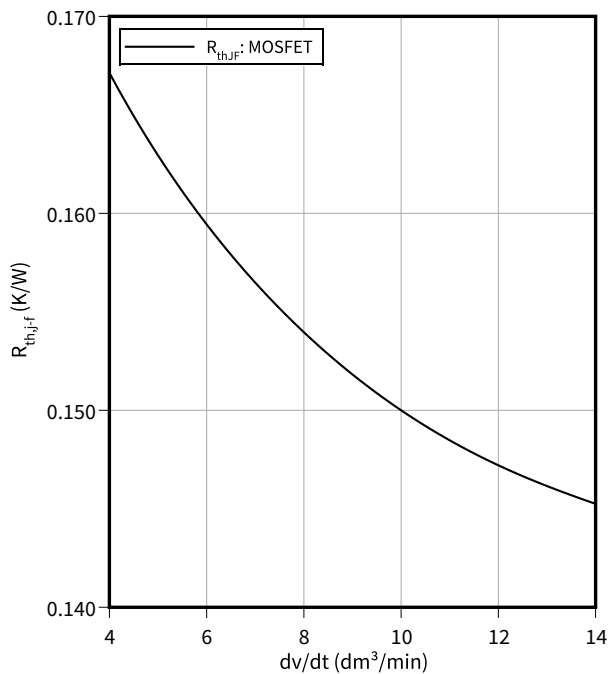
$Z_{th} = f(t)$



5 Characteristics diagrams

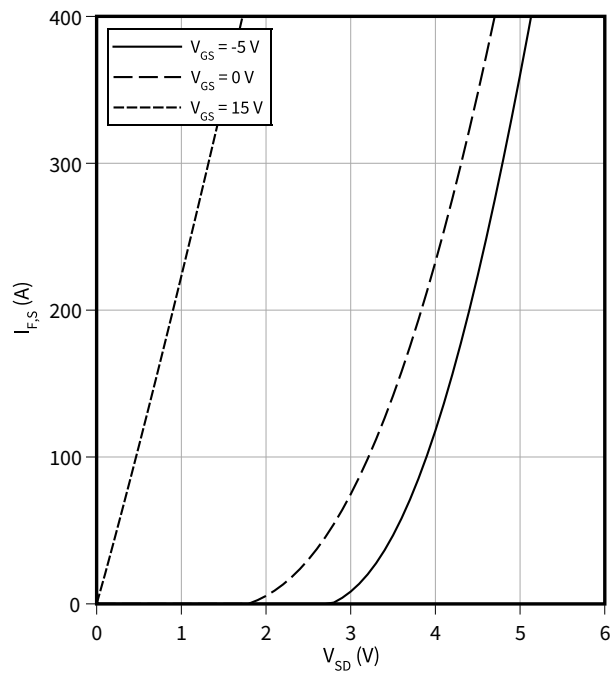
Thermal impedance , MOSFET

$R_{th,j-f} = f(dv/dt)$
fluid = 50% water/ 50% ethylenglycol , $T_f = 60\text{ °C}$



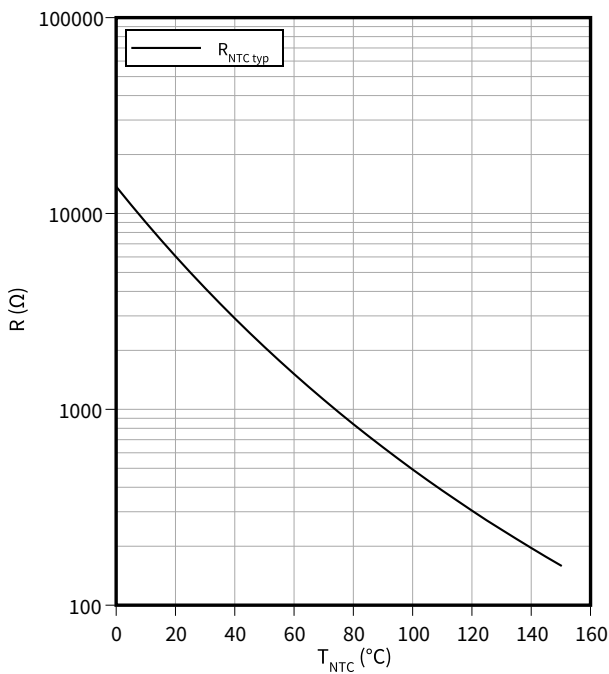
Forward characteristic body diode (typical), MOSFET

$I_{F,S} = f(V_{SD})$
 $T_{vj} = 25\text{ °C}$



Temperature characteristic (typical), NTC-Thermistor

$R = f(T_{NTC})$



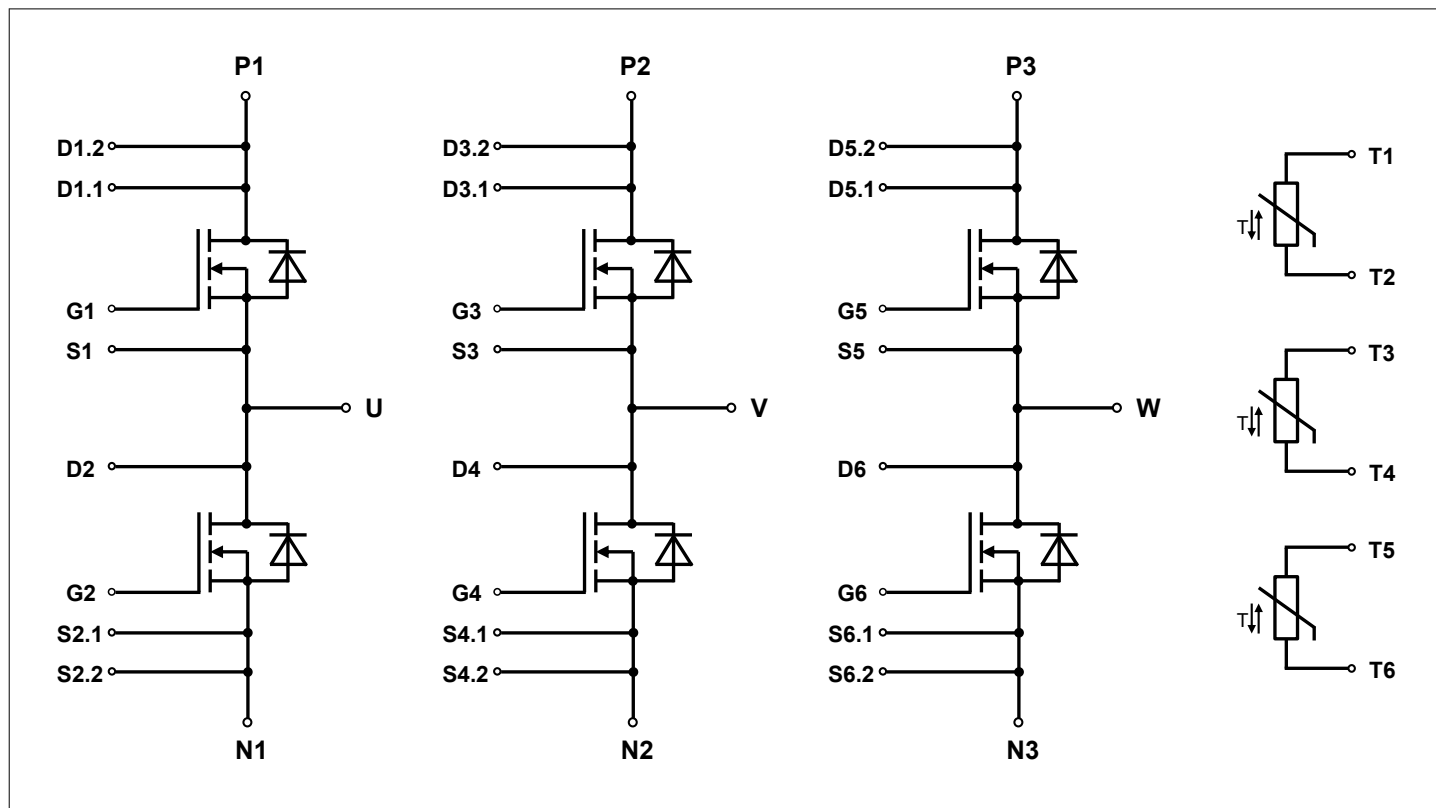


Figure 1

7 Package outlines

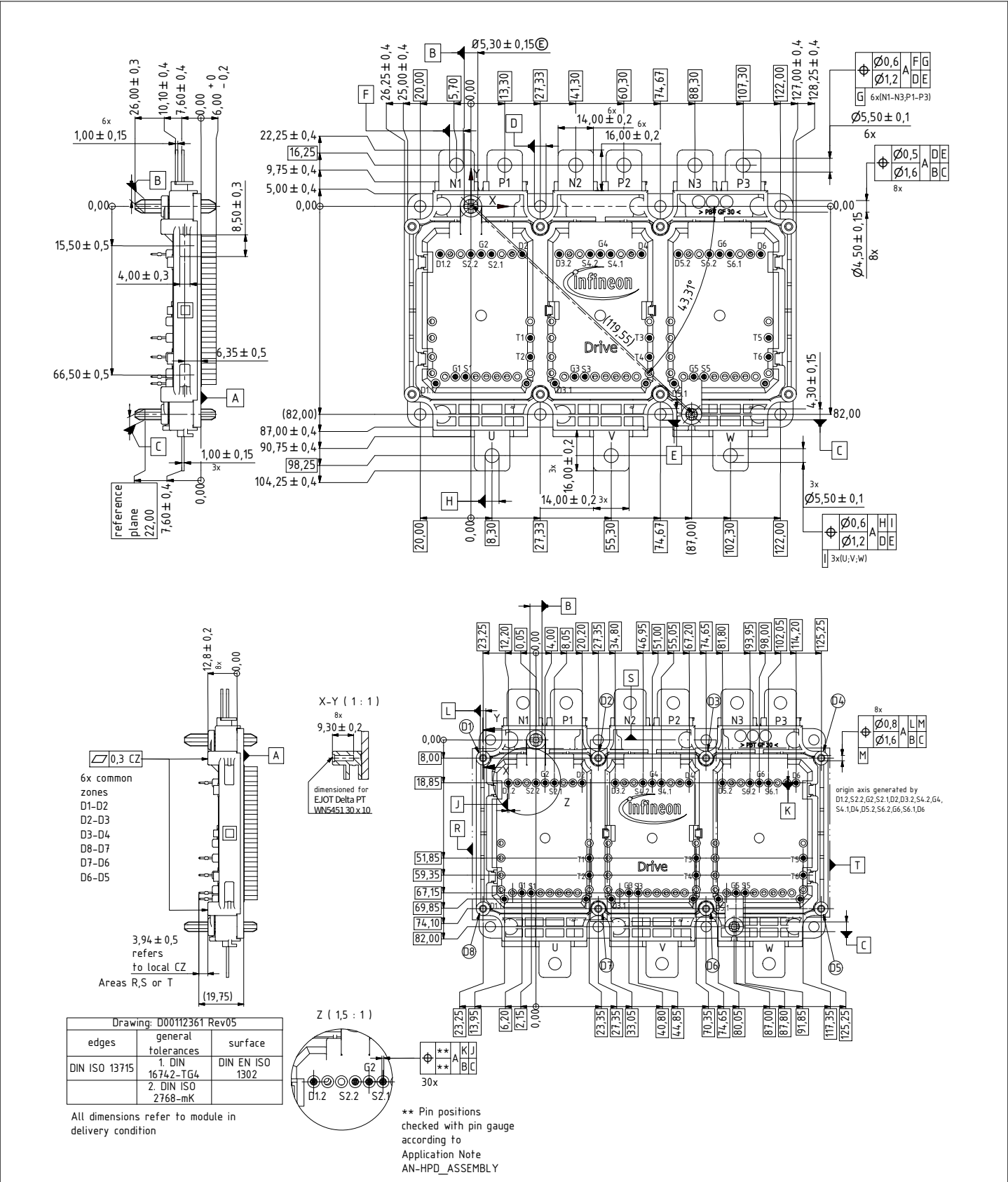


Figure 2

8 Module label code

Module label code				
Code format	Data Matrix		Barcode Code128	
Encoding	ASCII text		Code Set A	
Symbol size	16x16		23 digits	
Standard	IEC24720 and IEC16022		IEC8859-1	
Code content	<i>Content</i> Module serial number Module material number Production order number Date code (production year) Date code (production week)	<i>Digit</i> 1 – 5 6 - 11 12 - 19 20 – 21 22 – 23		<i>Example</i> 71549 142846 55054991 15 30
Example	  71549142846550549911530 71549142846550549911530			

Packing label code				
Code format	Barcode Code128			
Encoding	Code Set A			
Symbol size	34 digits			
Standard	IEC8859-1			
Code content	<i>Content</i> Module serial number Module material number Production order number Date code (production year) Date code (production week)	<i>Identifier</i> X 1T S 9D Q	<i>Digit</i> 2 – 9 12 – 19 21 – 25 28 – 31 33 – 34	<i>Example</i> 95056609 2X0003E0 754389 1139 15
Example	 X950566091T2X0003E0S754389D1139Q15			

Figure 3

Revision history

Document revision	Date of release	Description of changes
V1.0	2019-09-13	Target Datasheet
V2.0	2020-04-02	Preliminary Data Sheet
V3.0	2020-06-26	
V3.1	2020-09-17	Final datasheet, correction of module weight
n/a	2020-10-05	Datasheet migrated to a new system with a new layout and new revision number schema: target or preliminary datasheet = 0.xy; final datasheet = 1.xy
1.10	2022-07-19	Adaption of product identification Adding electrical feature diagram Correction of typos

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